Application/Control No. Applicant(s)/Patent Under Reexamination 10/695,061 KIM ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Matthew Landau 2815 **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2002/0195672	12-2002	Lee et al.	257/408
	В	US-6,734,564	05-2004	Cronin et al.	257/774
	С	US-6,294,449	09-2001	Wu et al.	438/597
	D	US-			
	Е	US-	-		
	F	US-			
	G	US-		,	
	Н	US-			
	_	US-			
	J	US-	,		
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	-2-				
	0					
	Р					
	σ					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	٦	
	>	
	>	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.